Anti-Site Defects in p-Type Co₂ZnO₄: Better than Perfect

Scientific Achievement

The Center for Inverse Design (CID) demonstrates that intrinsic anti-site defects actually improve electrical properties of Doping Type II spinels, in agreement with prior CID prediction.

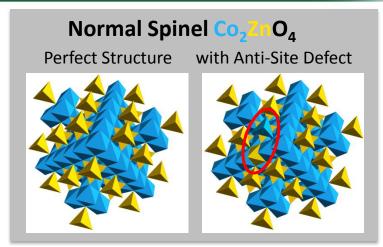
Significance and Impact

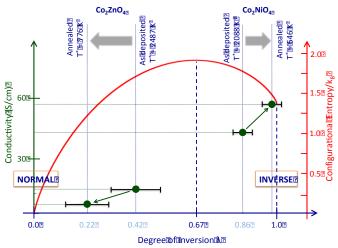
This work confirms a fundamental hole-generating process in Co_2ZnO_4 , thereby enabling increased p-type conductivity via intentional non-equilibrium growth.

Research Details

- *p*-type (hole-carrier) transparent conducting oxides are highly desired for photovoltaics and displays. However, to date, no *high-performance* materials are known.
- The CID previously predicted via theory that anti-site defects should be a net hole producer for a special class of III-II Normal spinels typified by Co₂ZnO₄ and denoted Doping Type II.
- Resonant (variable beam energy) elastic X-ray diffraction (REXD) measurements done
 on as-deposited and annealed epitaxial Co₂ZnO₄ films confirm this prediction.
- For *Inverse* spinel Co₂NiO₄, spin-dependent electronic structure calculations predict Co₂NiO₄ to be a spin-polarized semi-metal.
- Consequentially, for Co₂NiO₄, decreasing defects through annealing is predicted to increase conductivity—just the opposite of the predicted effect for Doping Type II Co₂ZnO₄. This is also confirmed by REXD measurements.
- These new insights into the role of anti-site disorder underpin a new Design Principle whereby non-equilibrium growth is used to create beneficial disorder.

P. Ndione, Y. Shi, V. Stevanovic, A. Zakutayev, S. Lany, P. Parilla, J. Perkins, J. Berry, D. Ginley, M. Toney, *Advanced Functional Materials*, submitted March 2013.





(Top) Perfect and anti-site defect structures for normal spinel Co₂ZnO₄. (Bottom) Electrical conductivity in *Normal* spinel Co₂ZnO₄ and *Inverse* spinel Co₂NiO₄.















